



VMDSEMI

**VFTT020R340NA**

**Datasheet**



VMDSEMI

## General Description

$V_{(BR)DSS}$	$R_{DS(ON)_{max}}$	$I_D$
200V	34mΩ@10V	36A
	57mΩ@4.5V	

## Symbol

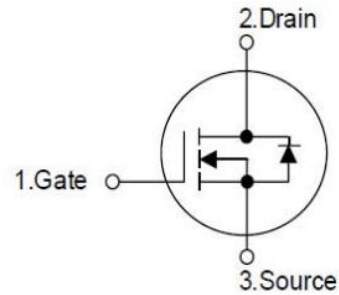


Figure 1 Symbol of VFTT020R340NA

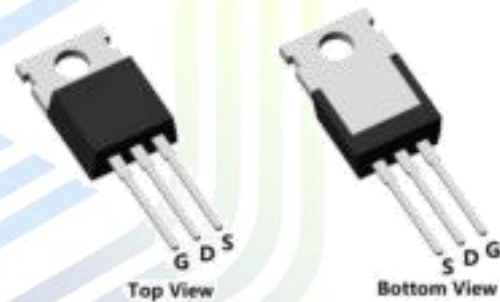
## Features

- High Speed Power Switching
- Low Gate Charge
- Enhanced Avalanche Ruggedness
- Enhanced Body diode dv/dt capability

## Application

- Switched mode power supply
- Solar inverter
- UPS and energy inverter
- Power Tools
- Motor Control

## Package Type



**TO-220**

Figure 2 Package Type of VFTT020R340NA

## Ordering Information

Product Name	Package
VFTT020R340NA	TO-220

**Absolute Maximum Ratings** ( $T_J = 25\text{ °C}$ , unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	200	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>Note 1</sup> $T_C = 25\text{ °C}$	$I_D$	36	A
Pulsed Drain Current <sup>Note 2</sup>	$I_{DM}$	110	A
Max Power Dissipation <sup>Note 3</sup> $T_C = 25\text{ °C}$	$P_D$	89.4	W
Avalanche Current, Single Pulse <sup>Note 4</sup>	$I_{AS}$	40	A
Avalanche Energy, Single Pulse <sup>Note 4</sup>	$E_{AS}$	183	mJ
Operation Junction temperature	$T_J$	-55 to 150	°C

**Thermal Resistance**

Parameter	Symbol	Min	Typ	Max	Unit
Thermal Resistance, Junction-to-Ambient <sup>Note 5</sup>	$R_{\theta JA}$		60		°C/W
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$		1.4		

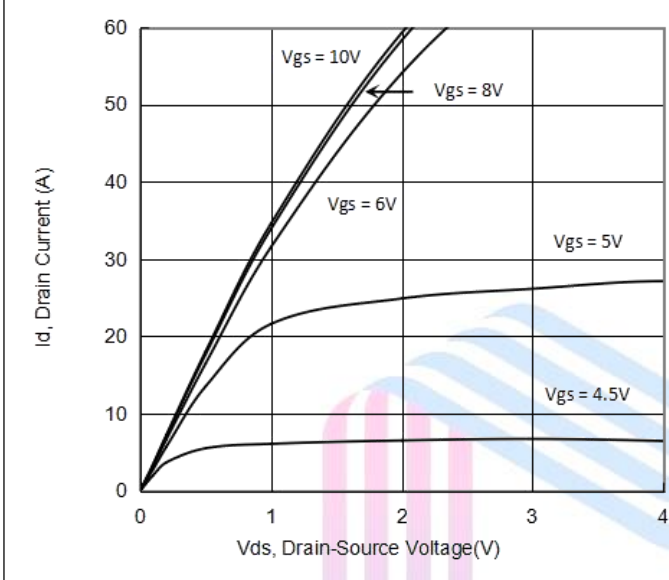
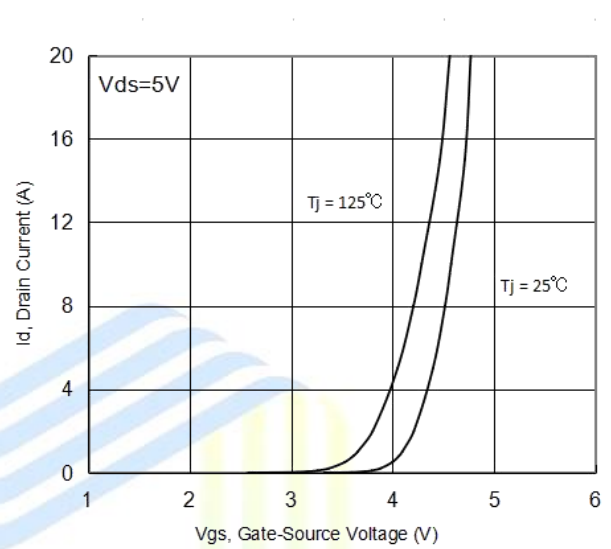
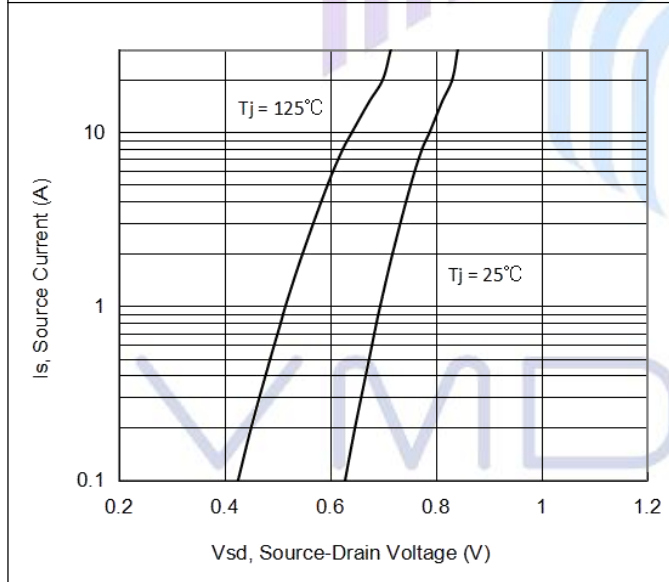
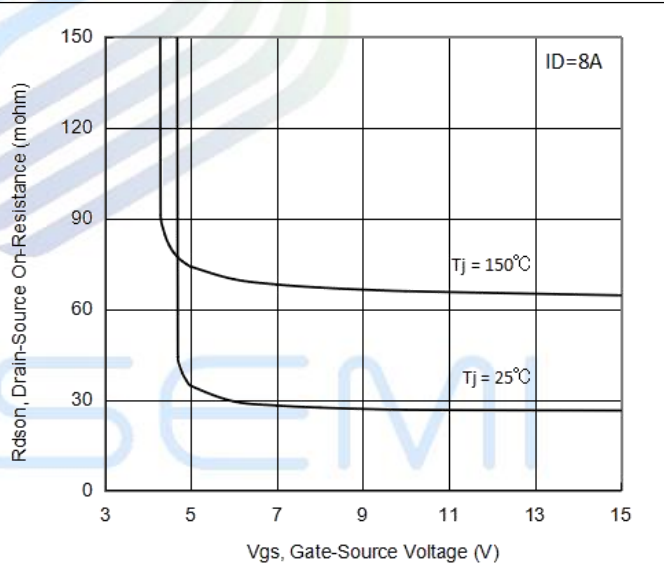
**Notes:**

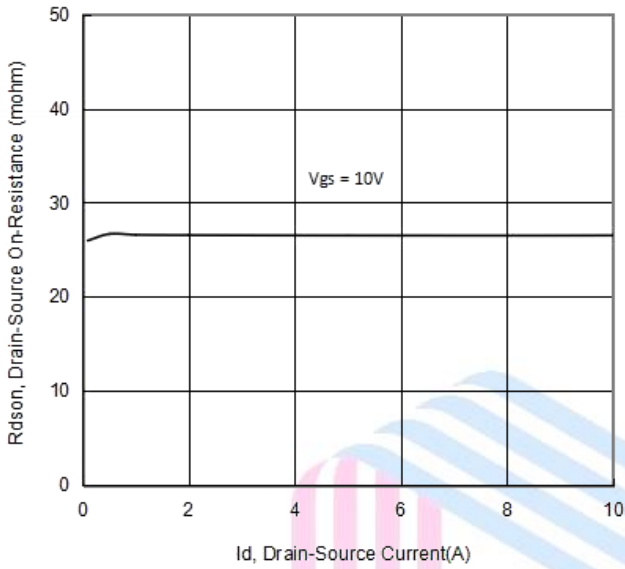
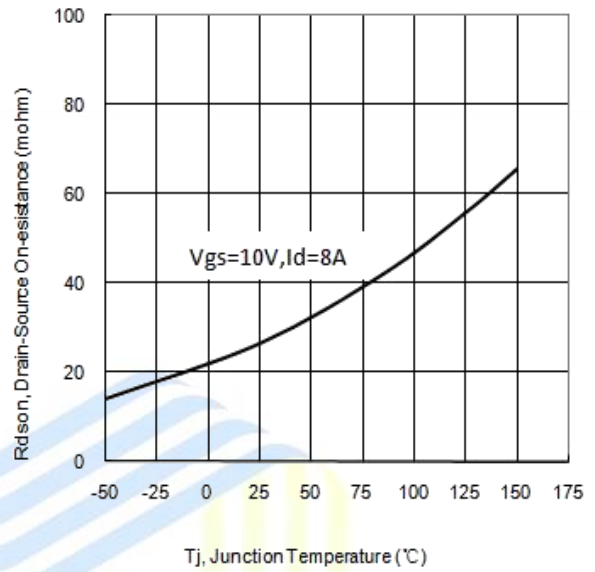
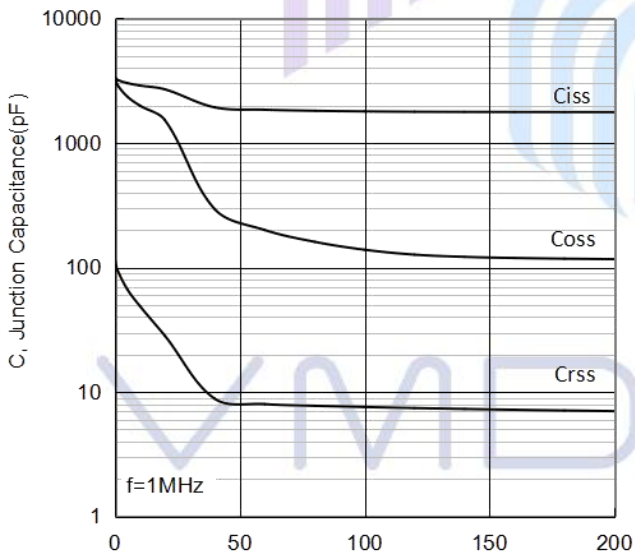
- 1) Calculated continuous current based on maximum allowable junction temperature  $T_{J(MAX)} = 150\text{ °C}$ .
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3)  $P_D$  is based on max. junction temperature, using junction-case thermal resistance.
- 4) EAS test condition:  $V_{DS} = 25\text{ V}$ ,  $V_{GS} = 10\text{ V}$ ,  $L = 0.4\text{ mH}$ ,  $R_g = 25\text{ }\Omega$ , starting  $T_J = 25\text{ °C}$ .
- 5) Device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25\text{ °C}$ .
- 6) Pulse Test : Pulse Width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .

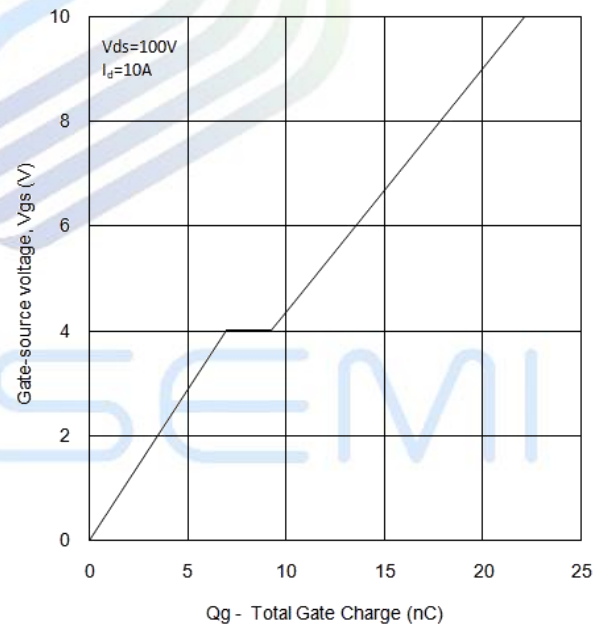
**Electrical Characteristics**( $T_J=25\text{ }^\circ\text{C}$ , unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>Statistic Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	200			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=160V, V_{GS}=0V$			1	$\mu A$
Gate-Body Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2	3.2	4	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=8A$		26.7	34	$m\Omega$
		$V_{GS}=4.5V, I_D=2A$		45.3	57	$m\Omega$
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{ISS}$	$V_{GS}=0V,$		1792		pF
Output Capacitance	$C_{OSS}$	$V_{DS}=100V,$		139		pF
Reverse Transfer Capacitance	$C_{RSS}$	$f=1MHz$		7.6		pF
Gate Resistance	$R_G$	$f=1MHz, \text{Open Drain}$		2.6		$\Omega$
Total Gate Charge (@ $V_{GS}=10V$ )	$Q_g$	$V_{GS}=0-10V$ $V_{DS}=100V$ $I_D=10A$		22.1		nC
Total Gate Charge (@ $V_{GS}=4.5V$ )	$Q_g$			10.3		
Gate to Source Charge	$Q_{gs}$			7.0		
Gate to Drain Charge	$Q_{gd}$			2.3		
<b>Switching Characteristics</b>						
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=100V$		13.8		ns
Rise Time	$t_r$	$I_D=10A$		24.7		
Turn-off Delay Time	$t_{d(off)}$	$V_{GS}=10V$		38.5		
Fall Time	$t_f$	$R_G=10\Omega$		20.5		
<b>Reverse Diode Characteristics</b>						
Drain-Source Diode Forward Voltage <sup>Note 6</sup>	$V_{SD}$	$V_{GS}=0V, I_{SD}=1A$		0.7	1.2	V
Body Diode Reverse Recovery Time	$t_{rr}$	$V_R=100V,$		91.4		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$I_F=10A, di/dt=100A/\mu s$		333.8		nC
Continuous Source Current, $T_C=25^\circ\text{C}$	$I_S$	--		36.8		A

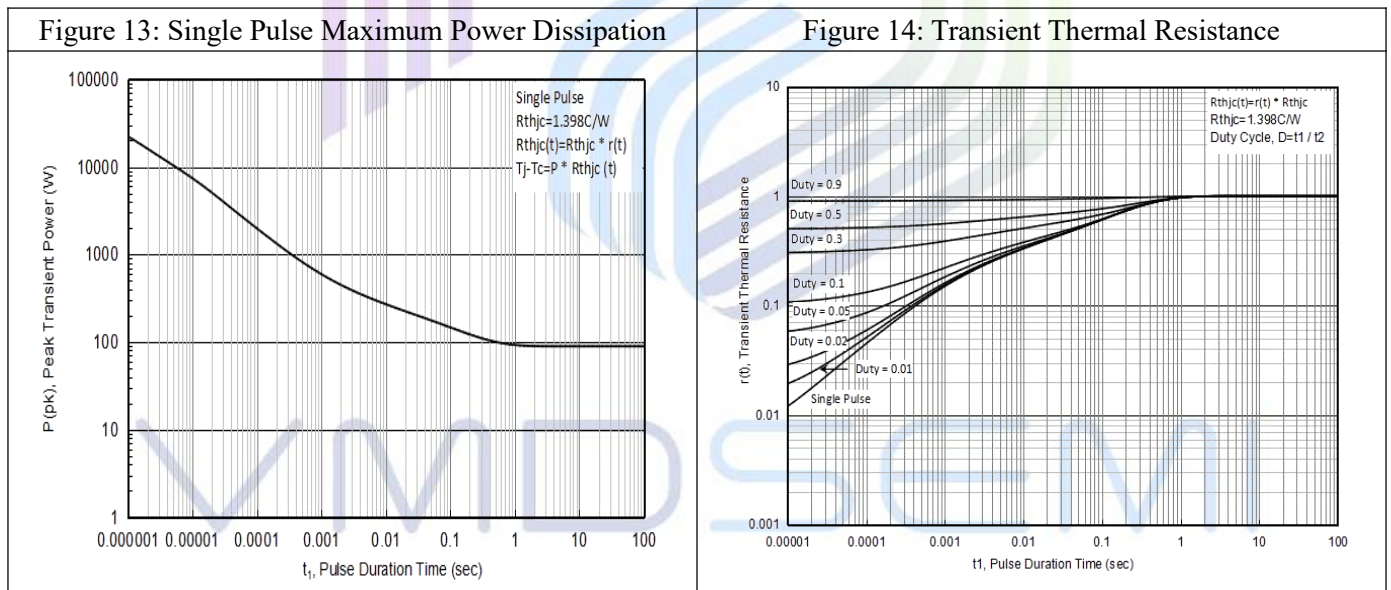
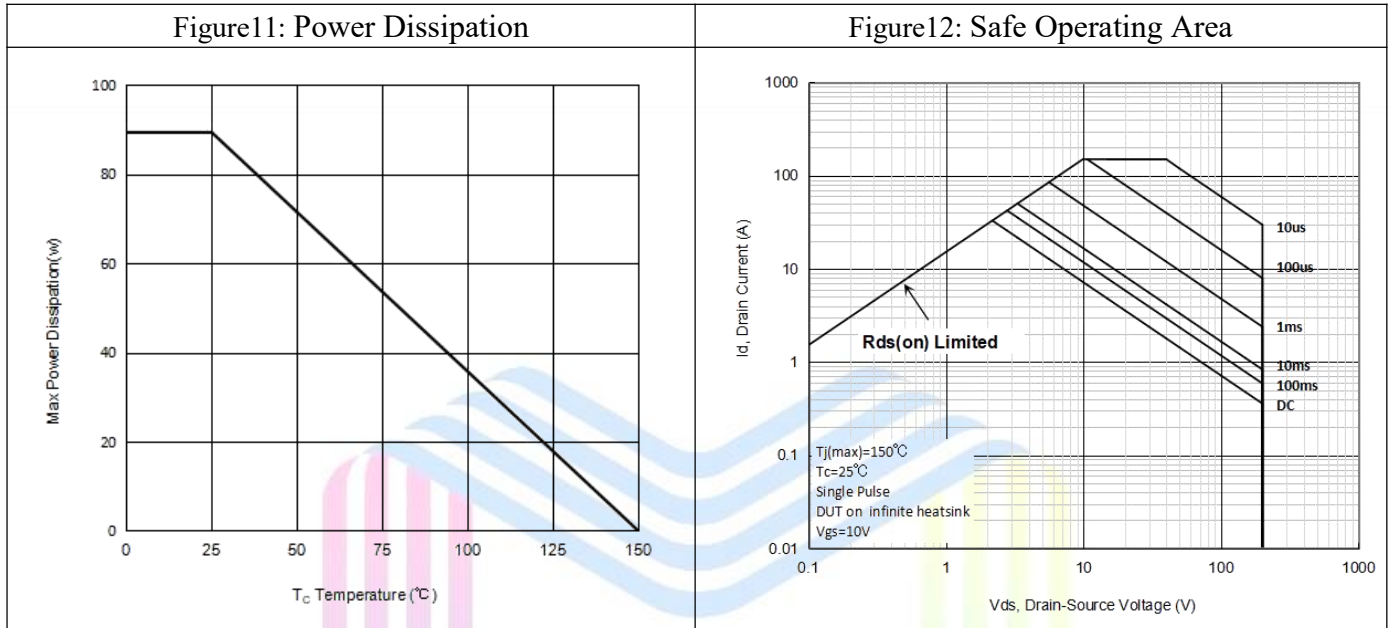
## Typical Performance Characteristics

**Figure 3: Typ. Output Characteristics**

**Figure 4: Typ. Transfer Characteristics**

**Figure 5: Forward Characteristics of Body Diode**

**Figure 6: On-Resistance vs. Gate-source voltage**


**Figure 7: Drain-Source Current On-State Resistance**

**Figure 8: Normalized Rdson vs Temperature**

**Figure 9: Typ. Capacitance**

**Figure: Typical Junction Capacitance**  
 Vds, Drain-Source Voltage(V)

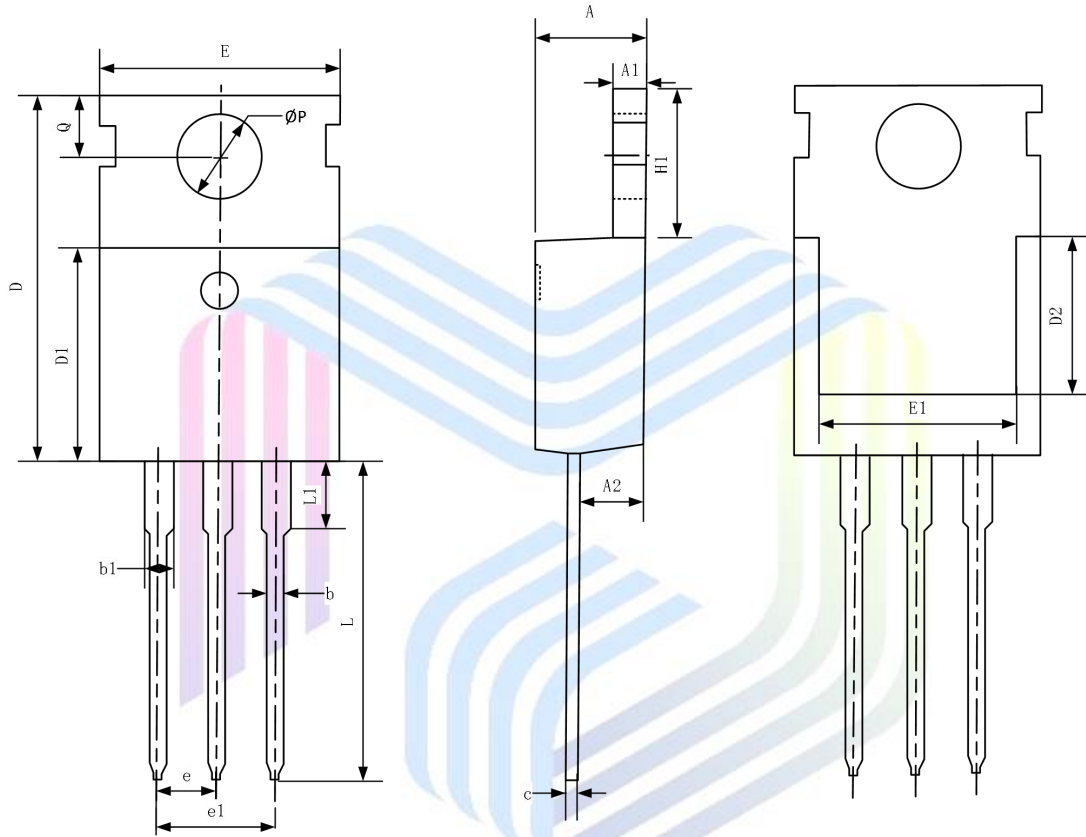
**Figure 10: Gate Charge Characteristics**


Qg - Total Gate Charge (nC)



## Mechanical Dimensions

### TO-220 Package Information



SYMBOL	MILLIMETER	
	MIN	MAX
A	4.37	4.70
A1	1.25	1.40
A2	2.20	2.60
b	0.70	0.95
b1	1.17	1.47
c	0.45	0.60
D	15.10	16.10
D1	8.80	9.40
D2	5.50	-
E	9.70	10.30
E1	7.00	-
e	2.54 BSC	
e1	5.08 BSC	
H1	6.25	6.85
L	12.75	13.80
L1	-	3.40
ØP	3.40	3.80
Q	2.60	3.00



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